Search Notes

Application/Con	trol	No.

Applicant(s)/Patent under Reexamination

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10/017,417 Examiner KIM, JONG-YOUN
Art Unit

Binh Q. Nguyen

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SEARCHED			
Class	Subclass	Date	Examiner
370	331	8/8/2005	BQN
370	468	8/8/2005	BQN
370	346	8/8/2005	BQN
370	333	8/8/2005	BQN
370	335	8/8/2005	BQN
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM-TDB) - See Search History Printout.	8/8/2005	BQN
Consider U.S. Patent: 6,339,590 and U.S. Patent: 6,665,281	8/8/2005	BQN